

Mitigation of Cr impurity Effects

Srikanth Gopalan, Soumendra Basu, Uday Pal, and Emily Ryan

Department of Mechanical Engineering and Division of Materials Science and Engineering

&

Hossein Ghezal-Ayagh

Fuel Cell Energy

Outline

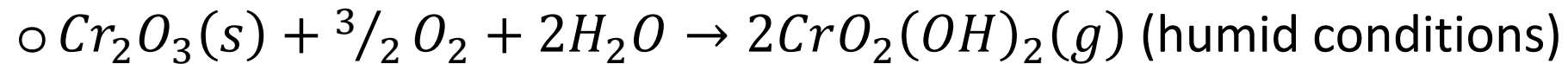
- Project objectives
- Recap of Cr poisoning mechanisms
- Role of thermodynamics and reactive transport
- Summary of ongoing work
- EPD coatings

Objectives of the project

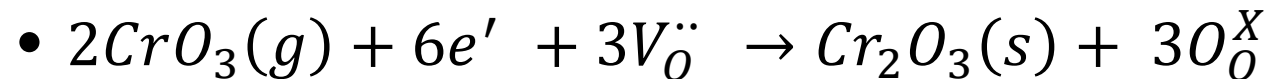
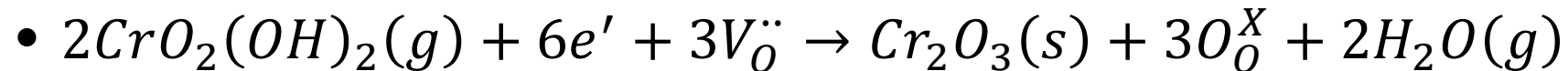
- Systematic approach to understanding the role of thermodynamics, reactive transport leading to formation of Cr-containing reaction products, and the cell and stack operating conditions, namely, temperature, cathode gas composition, and current density.
- To propose and demonstrate solutions to mitigate or eliminate the formation of deleterious phases that are rationally based in thermodynamics, kinetics, and transport.

Mechanisms of Cr poisoning

- Hilpert et al.



- Electrochemical reaction at cathode:

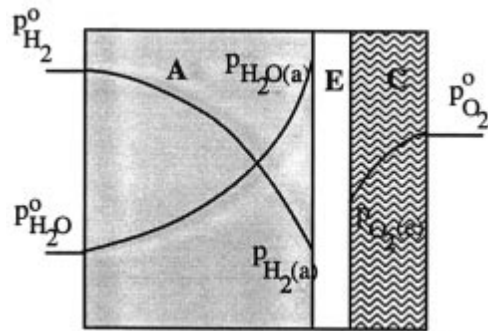


Mechanisms of Cr poisoning

- Cr in the gas phase and Mn in the LSM react directly to form Cr_2O_3 and eventually a manganese spinel, $(\text{Cr,Mn})_3\text{O}_4$. The Cr_2O_3 and spinel phases that form block the transport of oxygen to the TPBs thereby decreasing the oxygen partial pressure.
- The reduced oxygen partial pressure further drives the reaction of spinel formation.

The Role of Thermodynamics

- Current density and oxygen transport in the cathode determine the oxygen partial pressure distribution, and in particular the oxygen partial pressure at the cathode/electrolyte interface.



$$pO_2(c) = pO_2^o \exp\left[-\frac{4F\eta_c}{RT}\right]$$

Introduction: The Role of Thermodynamics

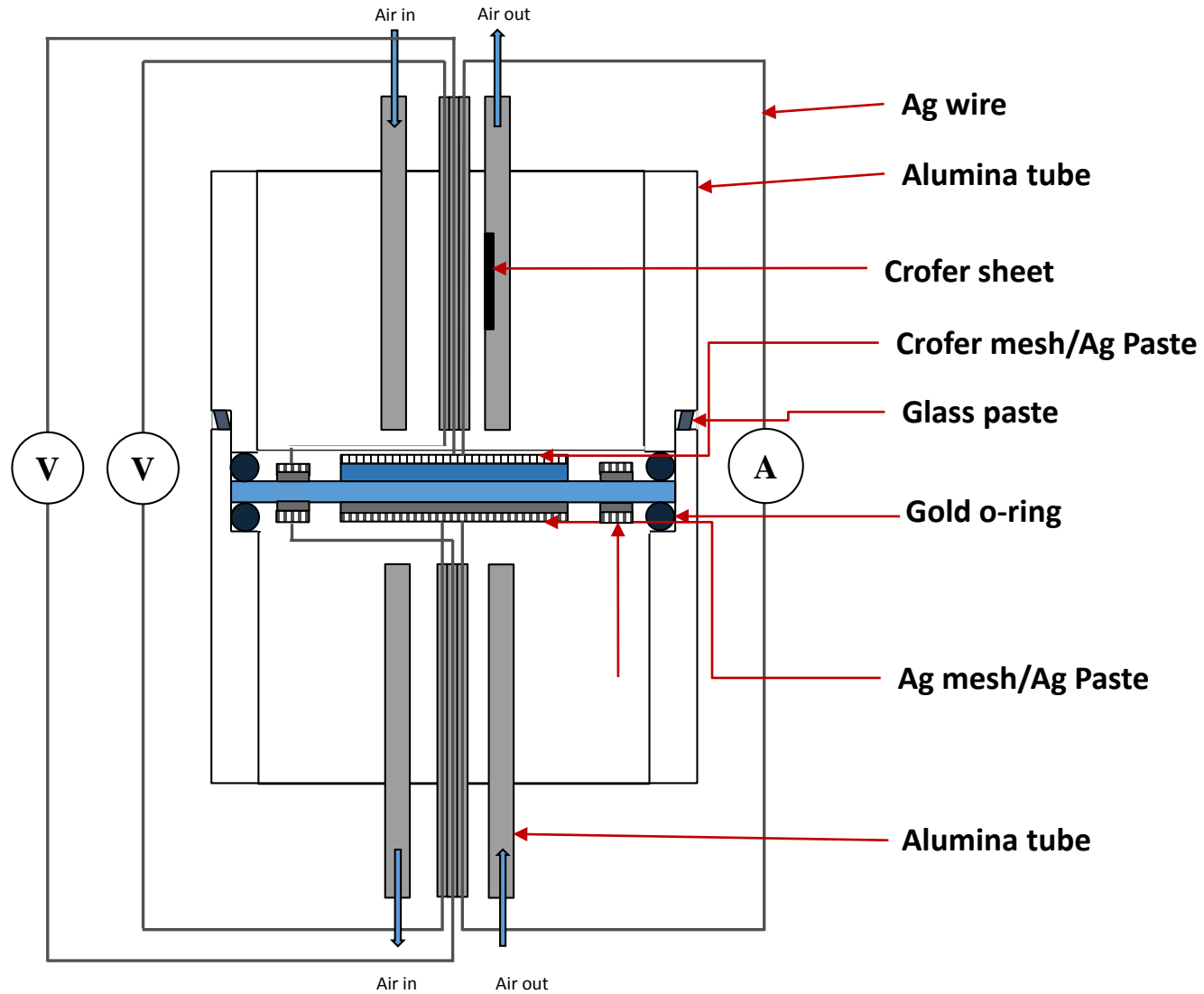
- Different compounds can form depending on the temperature and local oxygen partial pressure

Perovskite cathodes	Product	More stable at	
		$p(\text{O}_2)$ (Low<0.01 atm<High)	Temperature (Low<1000K<High)
$(\text{La}_{0.8}\text{Sr}_{0.2})\text{MnO}_3$	$p(\text{La}_{0.67}\text{MnO}_3)$	NA	Low
	$p(\text{LaMnO}_3)$	Both (slightly low preferred)	High
	$p(\text{SrMnO}_3)$	NA	High
	$p(\text{LaCrO}_3)$	High	High
	SrCrO_4	NA	Low
	La_2CrO_6	NA	Low
	$\alpha\text{-SrMnO}_3$	NA	Low
	$p(\text{SrMnO}_{2.5})$	Low	High
	$p(\text{SrCrO}_3)$	High	High
	Mn_3O_4	Low	High
	MnCr_2O_4	Low	NA
$(\text{La}_{0.8}\text{Sr}_{0.2})\text{FeO}_3$	$p(\text{LaFeO}_3)$	Both	Both
	$p(\text{SrFeO}_{2.5})$	Low	High
	$p(\text{LaCrO}_3)$	Low	High
	Fe_2O_3	NA	High
	SrCrO_3	Mid-range	High
	$\text{SrFe}_{12}\text{O}_{19}$	Both	Both
	SrCrO_4	High	Low
$\text{La}(\text{Ni}_{0.6}\text{Fe}_{0.4})\text{O}_3$	$p(\text{LaNiO}_3)$	High	Both
	$p(\text{LaFeO}_3)$	Both	Both
	NiO	Low	High
	La_2NiO_4	NA	High
	$p(\text{LaCrO}_3)$	Both	Both
	$\text{La}_4\text{Ni}_3\text{O}_{10}$	Low	High

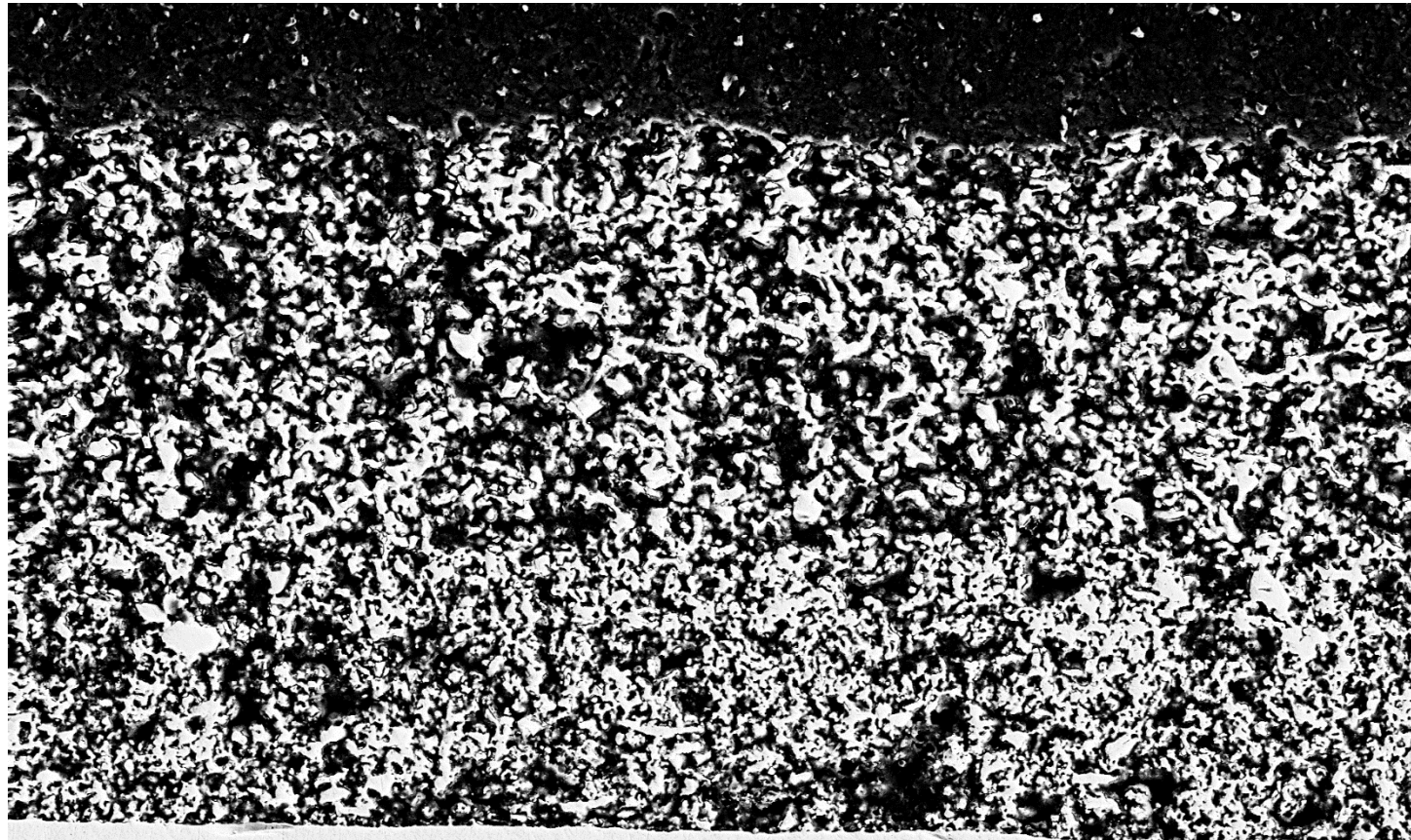
Summary of project tasks and overview of ongoing work

- Electrochemically testing symmetrical and full cells with exposure to Cr_2O_3 in a dry and humid atmosphere as a function of pH_2O (cathode), temperature, cathode microstructure, thickness, and current density.
- Microstructural and TEM/FIB analysis of tested cross-sections.
- Mapping of reaction products with pH_2O (cathode), temperature and current density.
- Computational modeling.
- Development of protective coatings

Schematic of electrochemical cell



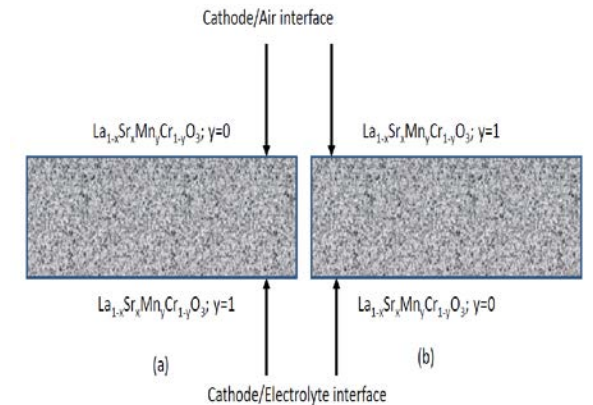
SEM image of cathode cross section (1200°C)



CCCL, 51.525 μm ,
Porosity: 49.74%

CAL, 34.068 μm ,
Porosity: 36.70%

YSZ, 7.672 μm



10 μm

Mag = 666 X

EHT = 7.00 kV

Signal A = SE2

Signal B = InLens

WD = 6.1 mm

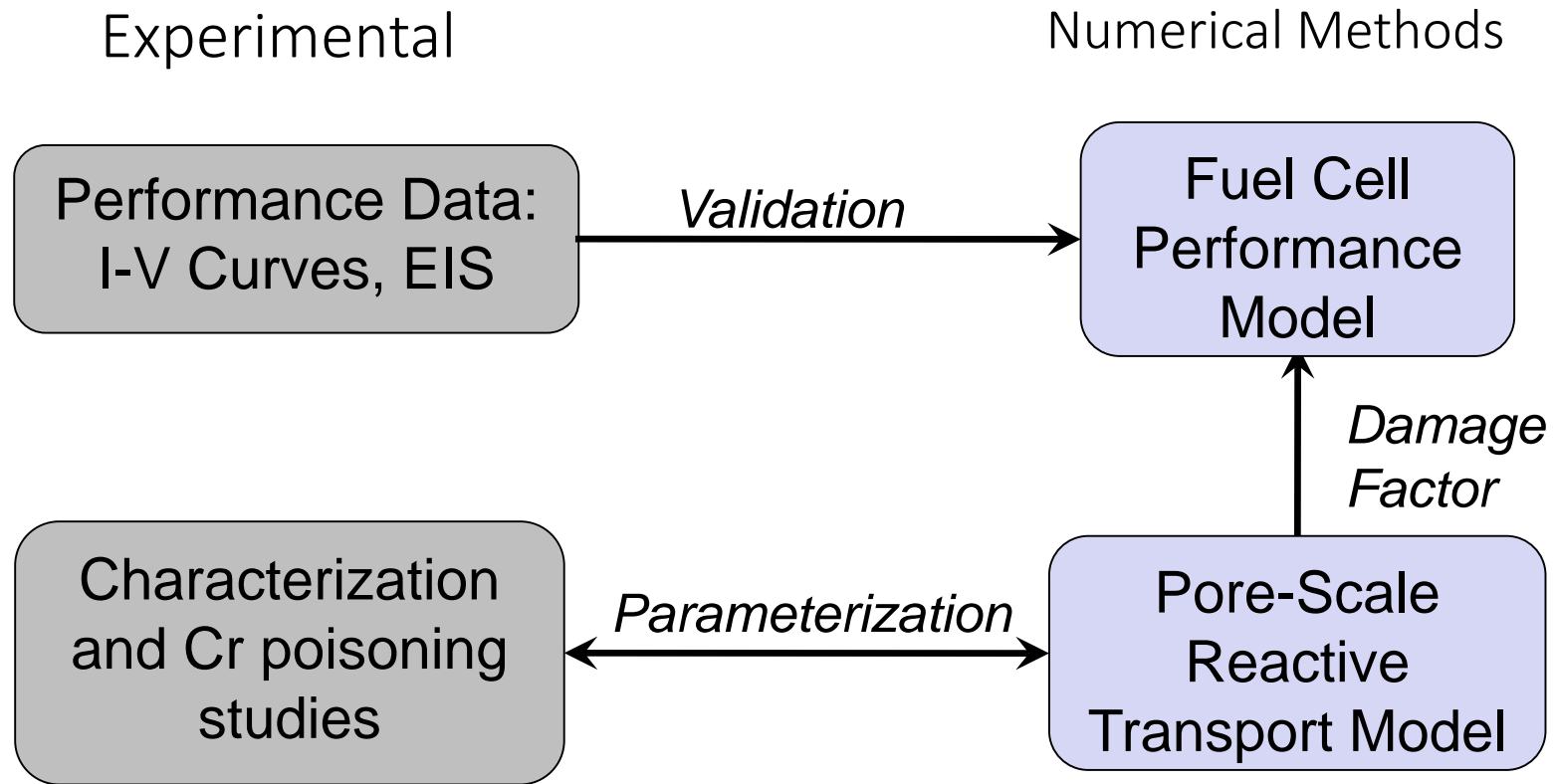
Aperture Size = 30.00 μm

Stage at T = 0.0 °

Date :22 Jun 2015

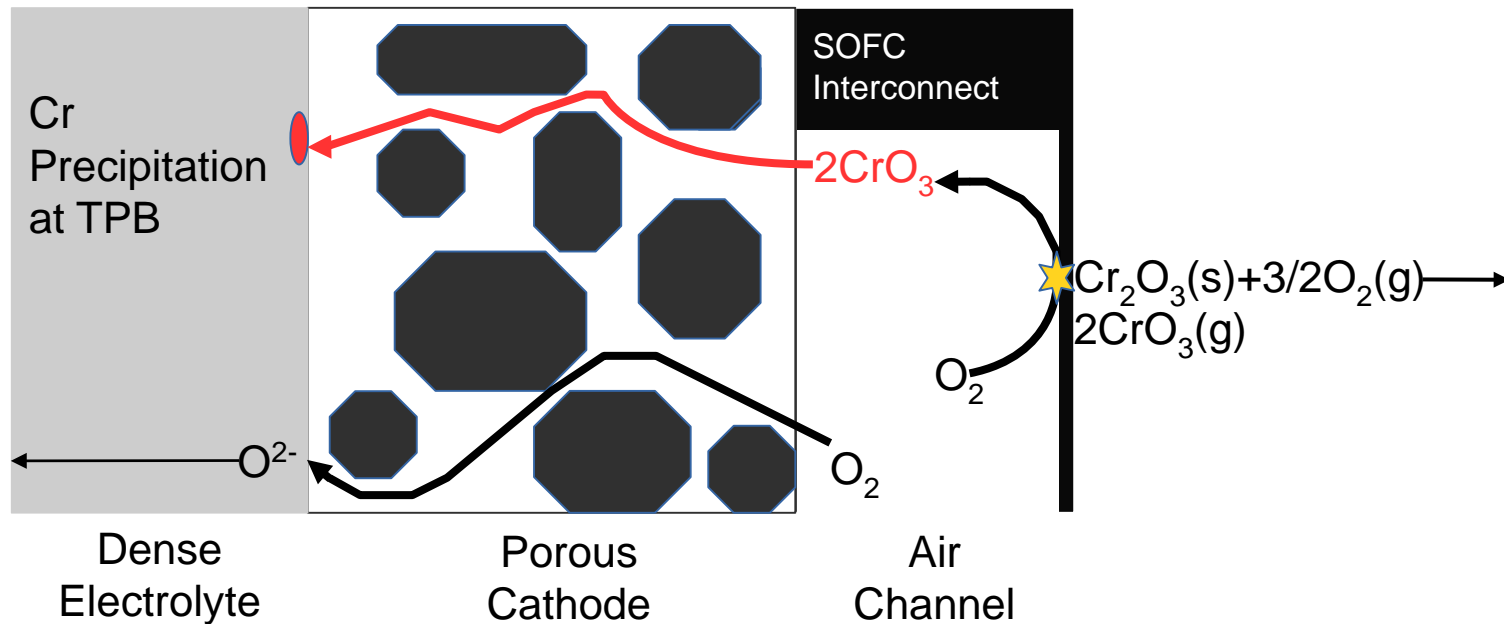


Computational Investigations of Chromium Poisoning



Pore-Scale Reactive Transport Model

- Develop a small scale model of reactive transport in the porous cathode
- Model will resolve cathode micro-structure
- Formulate a damage factor to include Cr poisoning in full cell performance model



BU Approach to Protective Coatings using EPD

Requirements of Protective Coatings

- Adherence with the substrate
- Stability (Thermodynamic & Thermomechanical)
- High electronic conductivity
- Low oxygen ion conductivity
- Spallation resistance (thermal cyclability)

Prior Candidates and Application Methods

- A number of spinel and perovskite coatings – e.g. $(\text{Mn,Co})_3\text{O}_4$, $(\text{Mn,Cr})_3\text{O}_4$, $\text{La}_{1-x}\text{Sr}_x\text{MnO}_3$, $\text{LaMn}_{0.9}\text{Ti}_{0.1}\text{O}_3$, $\text{La}_{1-x}\text{Sr}_x\text{CrO}_3$ etc.
- Atmospheric plasma spray (APS), aerosol deposition followed by sintering, sputtering, PVD etc.
- Principle issues have been adhesion to substrate, high density of coatings, and spallation of coatings after long term operation of cells.

BU Approach

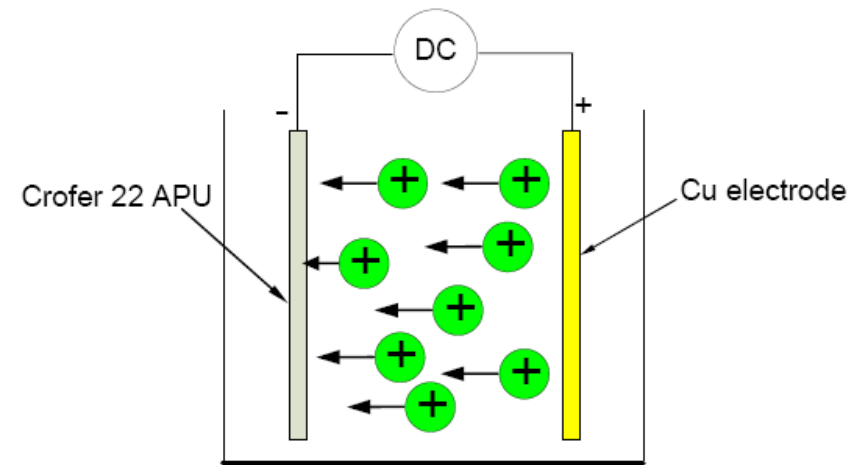
- Using a cost effective process-Electrophoretic Deposition (EPD) to apply a dense $\text{CuMn}_{1.8}\text{O}_4$ spinel oxide on Crofer 22 APU to reduce the oxidation of the alloy, minimize chromium transport and attack, and maintain a low interfacial resistance

Properties of $\text{CuMn}_{1.8}\text{O}_4$ Spinel

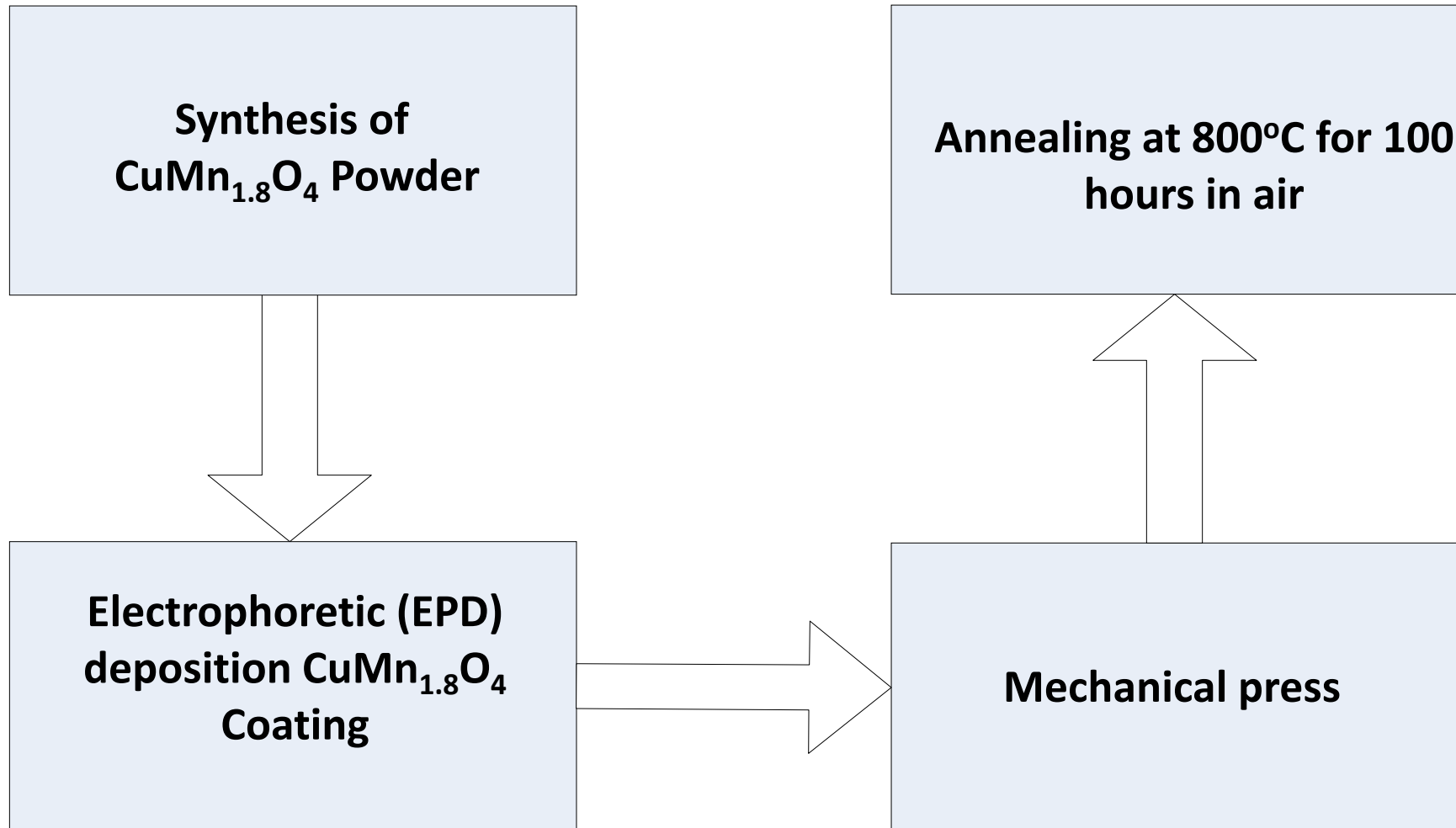
- Electrical conductivity of $\text{CuMn}_{1.8}\text{O}_4$ at 800 C is around 100S/cm

Material	Thermal expansion coefficient /K
$\text{CuMn}_{1.8}\text{O}_4$	12.2×10^{-6}
Crofer 22 APU	12.0×10^{-6}
LSM	12.0×10^{-6}
YSZ	11.0×10^{-6}

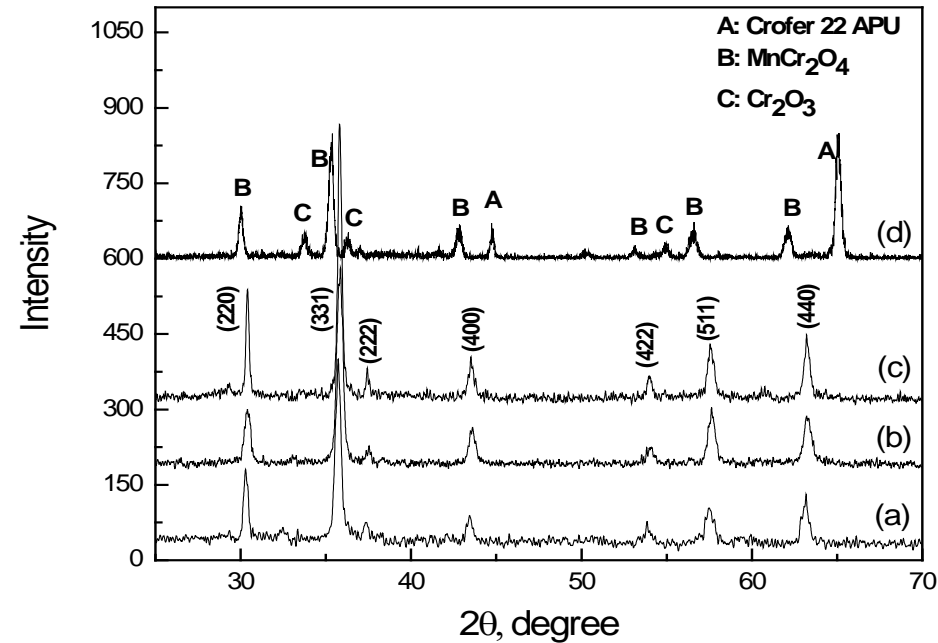
Electrophoretic Deposition Schematic



Coating Process

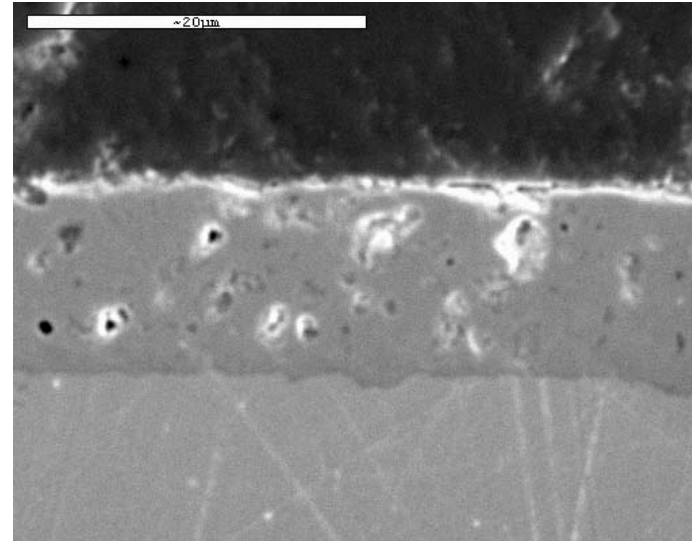
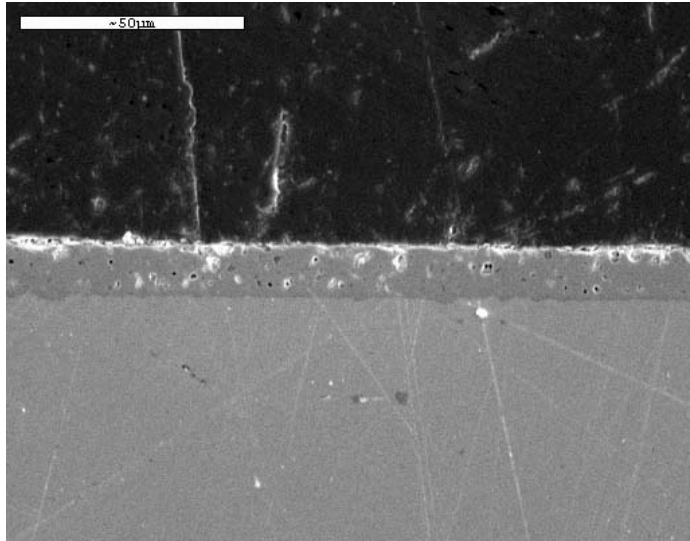


XRD of Coated and Uncoated Crofer 22 APU

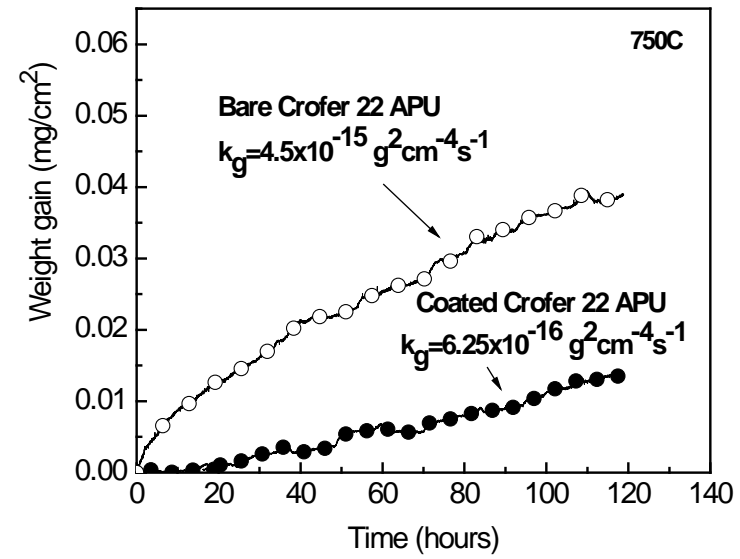
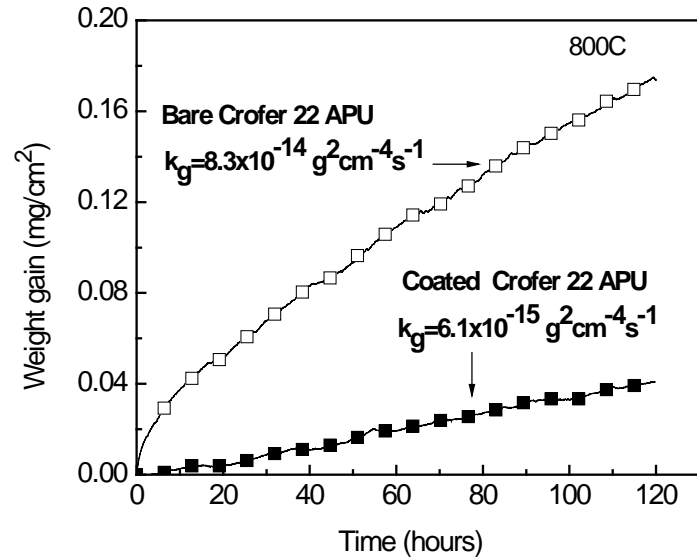


- (a) As-deposited $CuMn_{1.8}O_4$ coating sample,
- (b) Coated sample after 800°C 100h annealing
- (c) Coated sample (b) after 800°C 100h isothermal oxidation
- (d) Uncoated sample after 800°C 200h isothermal oxidation

Cross-Sectional SEM of Coated Sample



Weight Gain of Uncoated and Coated Samples

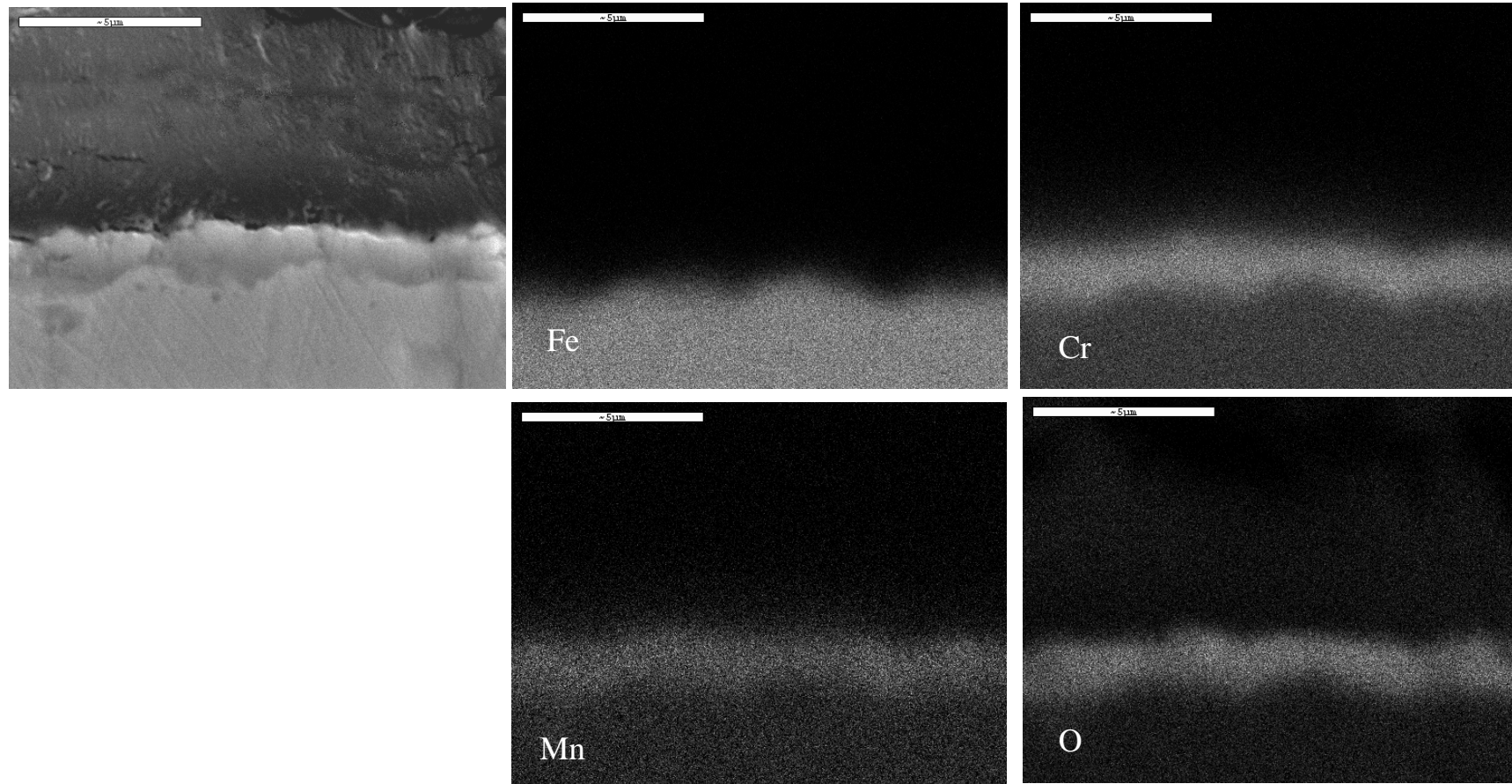


Oxidation Rate Parameters for Uncoated and Coated Samples

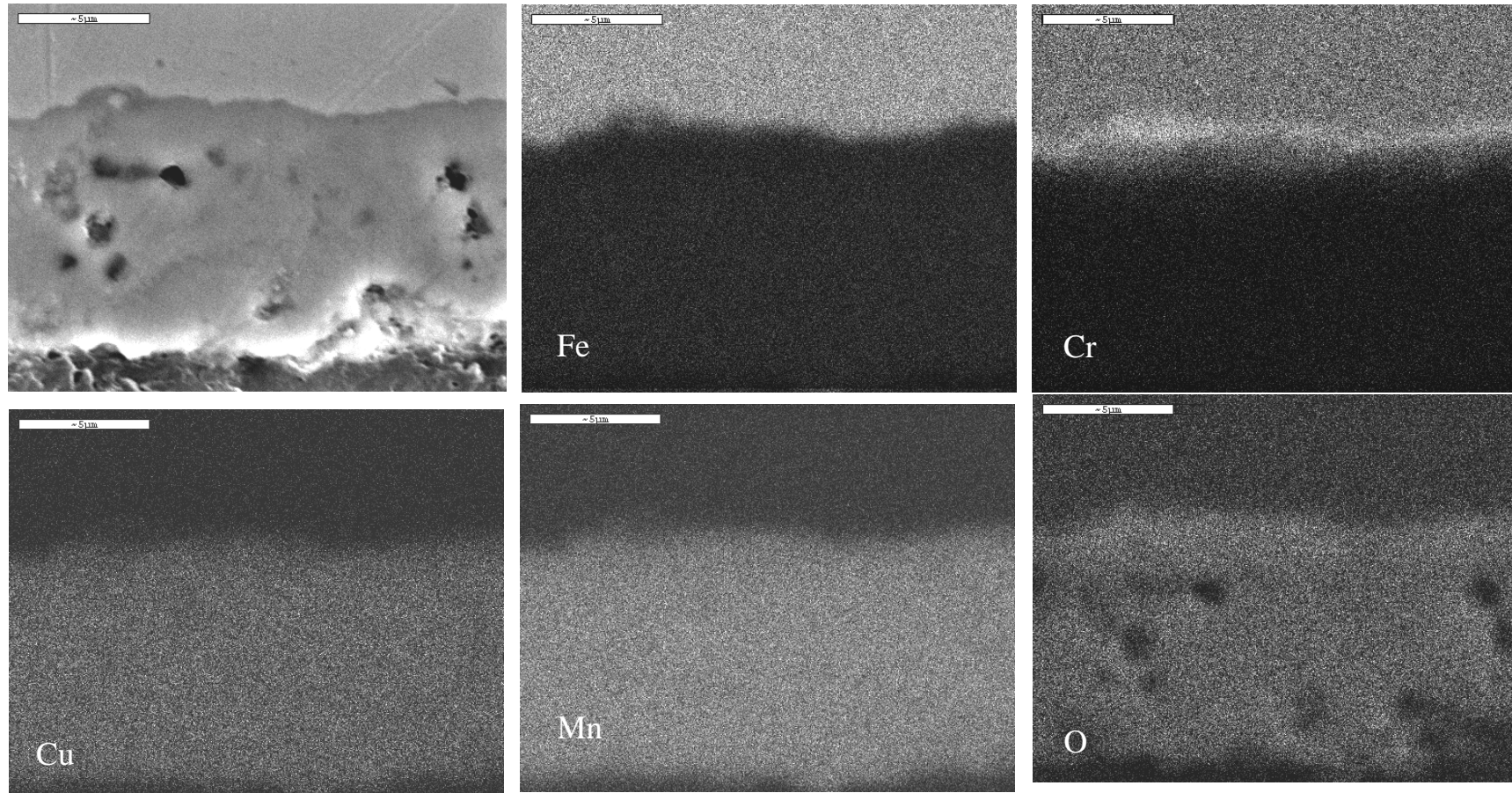
	Oxidation temperature (°C)	k_g ($\text{g}^2 \text{cm}^{-4} \text{s}^{-1}$)	k_p ($\mu\text{m h}^{-1/2}$)	Oxide thickness after 50000 h (μm)
Uncoated Crofer 22 APU	800	8.3×10^{-14}	10.51×10^{-2}	23.5
	750	4.5×10^{-15}	2.45×10^{-2}	5.5
Coated Crofer 22 APU	800	6.1×10^{-15}	2.87×10^{-2}	6.4
	750	6.25×10^{-16}	1.06×10^{-2}	2.4

$$k_p = 6 \times 10^5 \left[\frac{MW_{\text{Cr}_2\text{O}_3}}{(3/2)MW_{\text{O}_2}} \frac{1}{\rho_{\text{Cr}_2\text{O}_3}} \right] \sqrt{k_g}$$

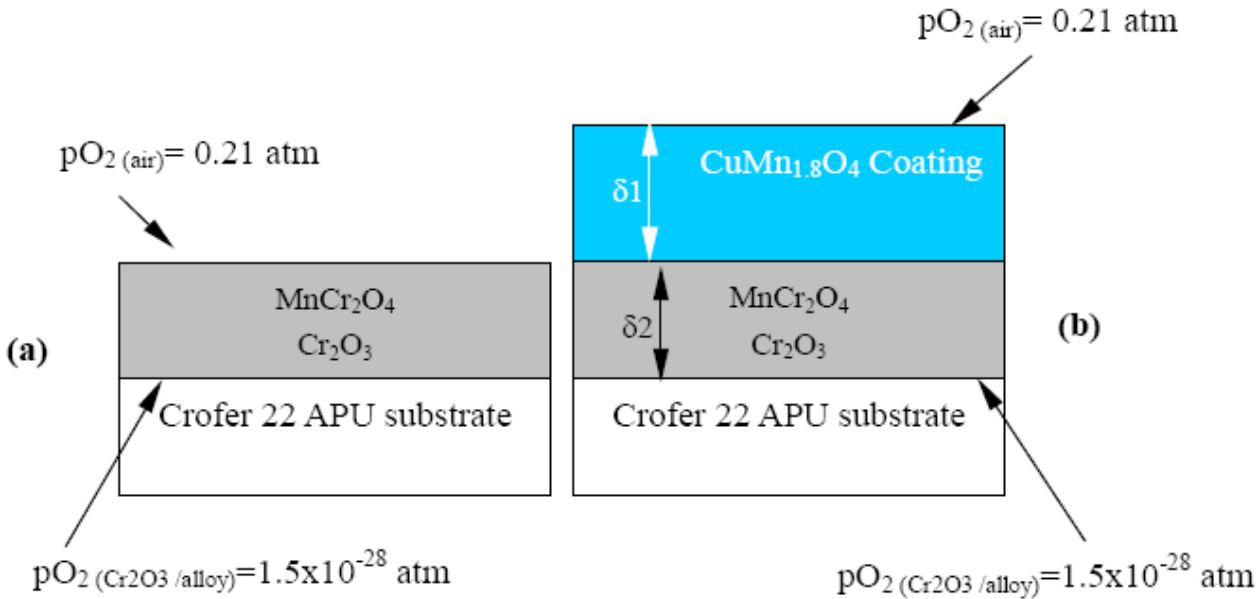
Elemental Distribution Map of Uncoated Sample after 800 °C, 120 h Isothermal Oxidation



Elemental Distribution Map of Coated Sample after 800 °C, 120 h Isothermal Oxidation



Schematic structure of oxide layer



(a) Uncoated Crofer 22 APU

(b) Coated Crofer 22 APU

Transport Model – Converting flux equations to rate of oxide layer growth

Flux due to chemical and electrostatic potential gradients:

$$j_{Cr^{3+}} = -\frac{\sigma_{Cr^{3+}}}{Z_{Cr^{3+}}^2 F^2} \left(\frac{d\mu_{Cr^{3+}}}{dx} + 3F \frac{d\Phi}{dx} \right)$$

$$j_{O^{2-}} = -\frac{\sigma_{O^{2-}}}{Z_{O^{2-}}^2 F^2} \left(\frac{d\mu_{O^{2-}}}{dx} - 2F \frac{d\Phi}{dx} \right)$$

$$j_n = -\frac{\sigma_n}{Z_n^2 F^2} \left(\frac{d\mu_n}{dx} - F \frac{d\Phi}{dx} \right)$$

$$|j_{Cr_2O_3}| = \left| \frac{1}{12} \left[\frac{\sigma_n (\sigma_{O^{2-}} + \sigma_{Cr^{3+}})}{F^2 (\sigma_{O^{2-}} + \sigma_{Cr^{3+}} + \sigma_n)} \right] \frac{d\mu_O}{dx} \right|$$

Oxide growth rate $\left(\frac{d\delta}{dt} \right)$

Effective diffusivity (D)

Oxygen partial pressure gradient $\left(\frac{d \ln pO_2}{dx} \right)$

Electroneutrality condition:

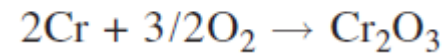
$$Z_{Cr^{3+}} j_{Cr^{3+}} + Z_{O^{2-}} j_{O^{2-}} + Z_n j_n = 0$$

Combining:

$$\frac{d\Phi}{dx} = \frac{1}{6} \left[\frac{3\sigma_{O^{2-}} \frac{d\mu_{O^{2-}}}{dx} + 6\sigma_n \frac{d\mu_n}{dx} - 2\sigma_{Cr^{3+}} \frac{d\mu_{Cr^{3+}}}{dx}}{F(\sigma_{O^{2-}} + \sigma_{Cr^{3+}} + \sigma_n)} \right]$$

$$\frac{d\delta}{dt} \frac{1}{D} dx = d \ln(pO_2)$$

Transport Model – Converting flux equations to rate of oxide layer growth



$$\Delta G = -1,120,300 + 260T \text{ J mol}^{-1} \text{ K}^{-1}$$

$p\text{O}_2$ at alloy/ Cr_2O_3 interface can be calculated from the above data and used in integrating oxide layer growth rate equation

$$\frac{d\delta_2}{dt} = \frac{\Delta \ln(p\text{O}_2)}{\frac{\delta_1}{D_1} + \frac{\delta_2}{D_2}} = \frac{a}{b + \delta_2}$$

$$a = D_2 \Delta \ln(p\text{O}_2) \text{ and } b = \delta_1 D_2 / D_1$$

$$\frac{\delta_2}{2\Delta \ln(p\text{O}_2) \frac{D_2}{\delta_2}} + \frac{\delta_2}{\Delta \ln(p\text{O}_2) \frac{D_1}{\delta_1}} = t + \tau$$

- Initial stage – scale thickness small; growth rate dominated by transport through coating, linear kinetics
- Later stage – scale thickness large; growth rate dominated by transport through scale, parabolic kinetics.
- Intermediate stage – transition regime, parabolic kinetics

Data Analysis

	Oxidation temperature (C)	K_g ($\text{g}^2/\text{cm}^4\text{s}$)	D_1 (cm^2/s)	D_2 (cm^2/s)	Total oxide thickness (μm)
Uncoated Crofer 22 APU	800	6.67×10^{-14}	NA	2.5×10^{-16}	1.1
	750	3.64×10^{-15}	NA	1.6×10^{-17}	0.55
Coated Crofer 22 APU	800	NA	2.0×10^{-15}	2.5×10^{-16}	0.7
	750	NA	5.0×10^{-16}	1.6×10^{-17}	0.25

δ_1/D_1 and δ_2/D_2 are the contributions of diffusion resistances from coating and scale

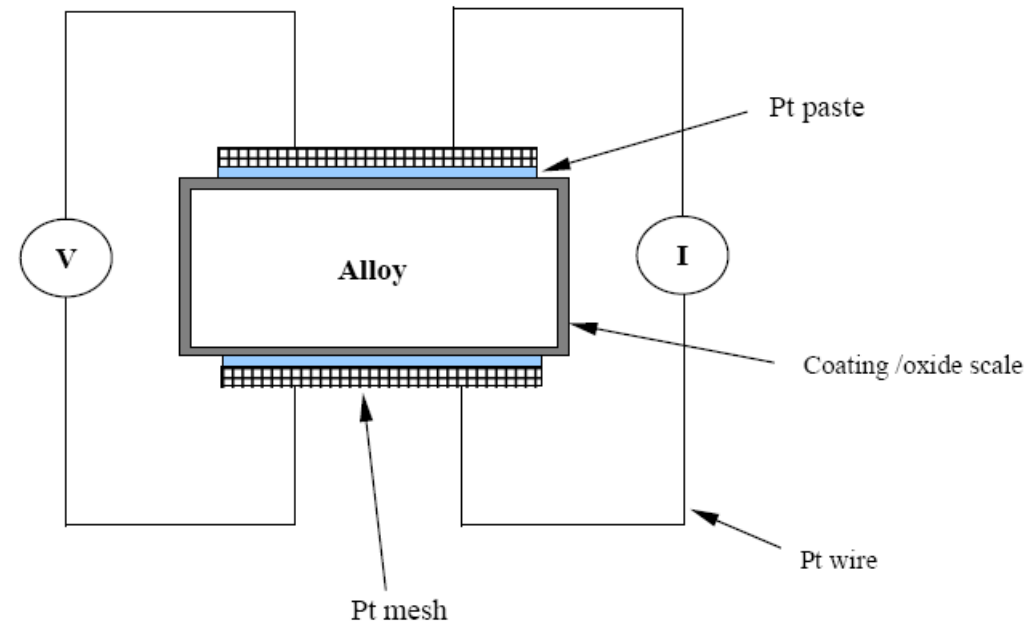
Based on our analysis of the data:

Equal contributions from coating and scale occurs at 850 h at 800°C

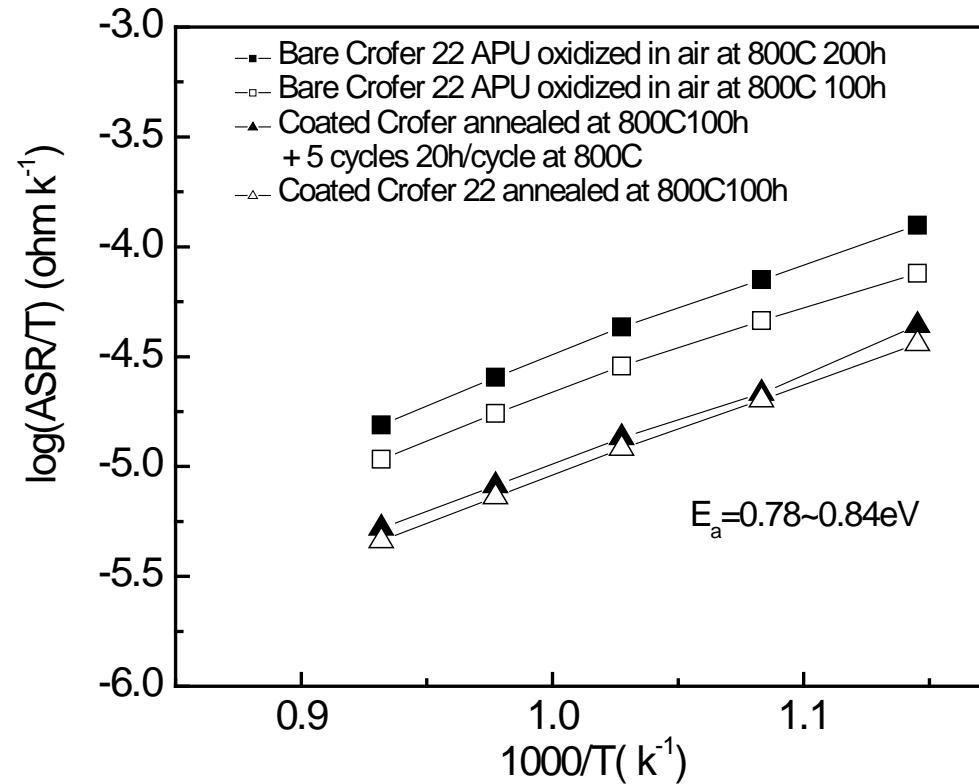
Equal contributions from coating and scale occurs at 100 h at 750°C

Our measurements at both temperatures were for 120 h. Thus 800°C data follow linear kinetics and 750°C data follow parabolic kinetics

Schematic of ASR measurement setup



ASR as a function of temperature for the various samples



Predicted long time ASR

	temperature (°C)	Oxide thickness after 50000 h (μm)	Resistivity of Cr_2O_3 ($\text{m}\Omega\text{cm}$)*	ASR after 50000 h ($\text{m}\Omega\text{cm}^2$)
Coated Crofer 22 APU	800	6.4	1.7×10^4	11
	750	2.4	2×10^4	4.8

* W. Qu, etc, J. Power Sources, 153(1), 114 (2006)

Target Interconnect ASR $\leq 100\text{m}\Omega\text{cm}^2$

Future work on coatings

- Other materials compositions to be explored through EPD technique
- Transport in newer coating materials can be altered by suitable doping strategies and engineering the point defect structure

Acknowledgments

- DOE personnel -- Steven Markovich, Rin Burke, Shailesh Vora
- Wenhua Huang – Former graduate student (EPD coatings work)